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October 2014

FDMS5352

N-Channel Power Trench[®] MOSFET 60V, 49A, $6.7m\Omega$

Features

- Max $r_{DS(on)} = 6.7 \text{m}\Omega$ at $V_{GS} = 10 \text{V}$, $I_D = 13.6 \text{A}$
- Max $r_{DS(on)}$ = 8.2m Ω at V_{GS} = 4.5V, I_D = 12.3A
- Advanced Package and Silicon combination for low r_{DS(on)}
- MSL1 robust package design
- 100% UIL Tested
- RoHS Compliant

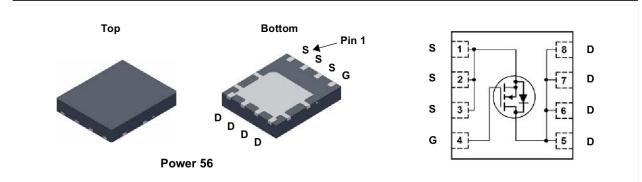


General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

■ DC - DC Conversion



MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			60	V	
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T _C = 25°C		49		
	-Continuous (Silicon limited)	T _C = 25°C		88		
'D	-Continuous	T _A = 25°C	(Note 1a)	13.6	_ A	
	-Pulsed			100		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	600	mJ	
Б	Power Dissipation	T _C = 25°C		104	14/	
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	2.5	W	
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS5352	FDMS5352	Power 56	13"	12mm	3000 units

Electrical Characteristics T_J = 25°C unless otherwise noted Parameter

Off Characteristics								
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$	60			V		
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		57		mV/°C		
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0V, V _{DS} = 48V,			1	μА		
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA		

Test Conditions

Min

Тур

Max

Units

On Characteristics

Symbol

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.8	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C		-6.6		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10V, I _D = 13.6A		5.6	6.7	
		$V_{GS} = 4.5V, I_D = 12.3A$		6.7	8.2	mΩ
, ,		$V_{GS} = 10V$, $I_D = 13.6A$, $T_J = 125$ °C		9.7	11.6	
g _{FS}	Forward Transconductance	$V_{DD} = 5V, I_{D} = 13.6A$		76		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 30V, V _{GS} = 0V, f = 1MHz		5220	6940	pF
C _{oss}	Output Capacitance			410	545	pF
C _{rss}	Reverse Transfer Capacitance			225	335	pF
R_g	Gate Resistance	f = 1MHz	0.1	1.3	2.6	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time				19	34	ns
t _r	Rise Time	V _{DD} = 30V, I _D = 1	$V_{DD} = 30V, I_D = 13.6A,$		11	21	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10V, R _{GEN}	$V_{GS} = 10V, R_{GEN} = 6\Omega$		58	93	ns
t _f	Fall Time				7	15	ns
Q_g	Total Gate Charge	V _{GS} =0Vto10V			93	131	nC
Q_g	Total Gate Charge	$V_{GS} = 0V \text{ to } 5V$	$V_{GS} = 0V \text{ to } 5V$ $V_{DD} = 30V$,		48	67	nC
Q _{gs}	Gate to Source Charge		I _D = 13.6A		14		nC
Q_{gd}	Gate to Drain "Miller" Charge				17		nC

Drain-Source Diode Characteristics

V	Veb Source to Drain Dioge Forward Voltage	V _{GS} = 0V, I _S = 13.6A (Note 2)	0.8	1.3	V
VSD		$V_{GS} = 0V, I_S = 2.1A$ (Note 2)	0.7	1.2	
t _{rr}	Reverse Recovery Time	I _E = 13.6A, di/dt = 100A/μs	39	63	ns
Q _{rr}	Reverse Recovery Charge	1 _F = 13.6A, di/dt = 100A/μs	48	77	nC

^{1.} R_{0,JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a. 50°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < $300\mu s$, Duty cycle < 2.0%.
- 3. Starting T_J = 25°C, L = 3mH, I_{AS} = 20A, V_{DD} = 60V, V_{GS} = 10V

Typical Characteristics T_J = 25°C unless otherwise noted

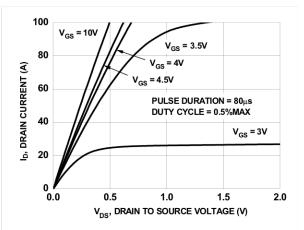


Figure 1. On-Region Characteristics

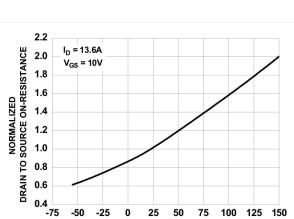


Figure 3. Normalized On-Resistance vs Junction Temperature

T_J, JUNCTION TEMPERATURE (°C)

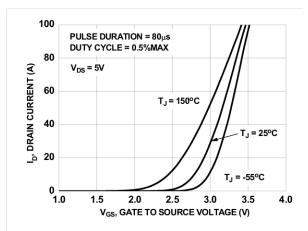


Figure 5. Transfer Characteristics

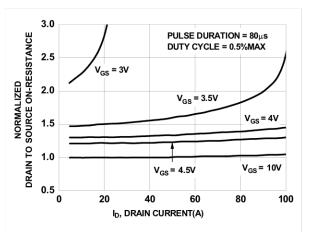


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

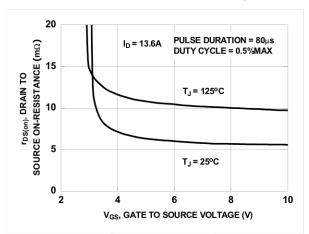


Figure 4. On-Resistance vs Gate to Source Voltage

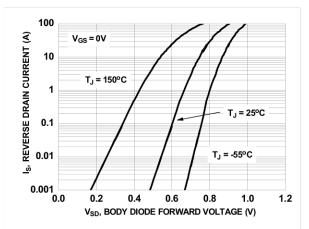


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

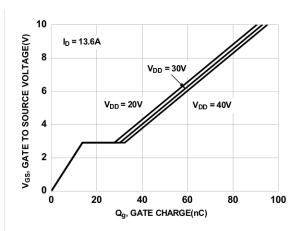


Figure 7. Gate Charge Characteristics

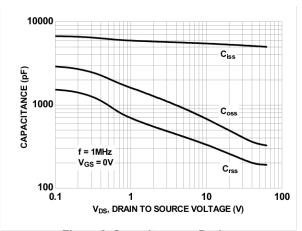


Figure 8. Capacitance vs Drain to Source Voltage

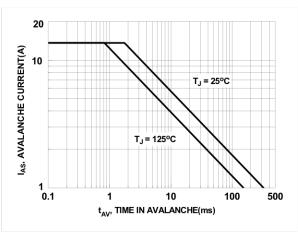


Figure 9. Unclamped Inductive Switching Capability

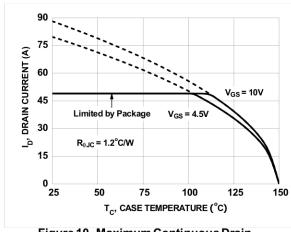


Figure 10. Maximum Continuous Drain Current vs Case Temperature

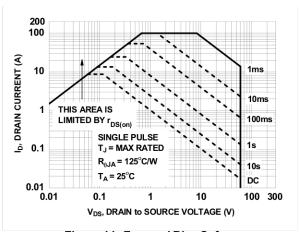


Figure 11. Forward Bias Safe Operating Area

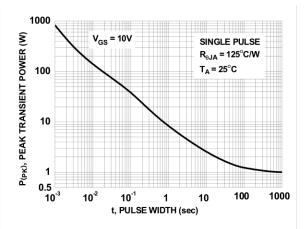


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

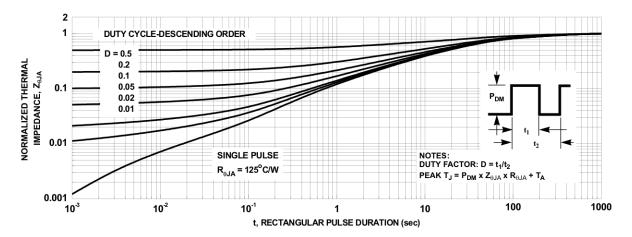
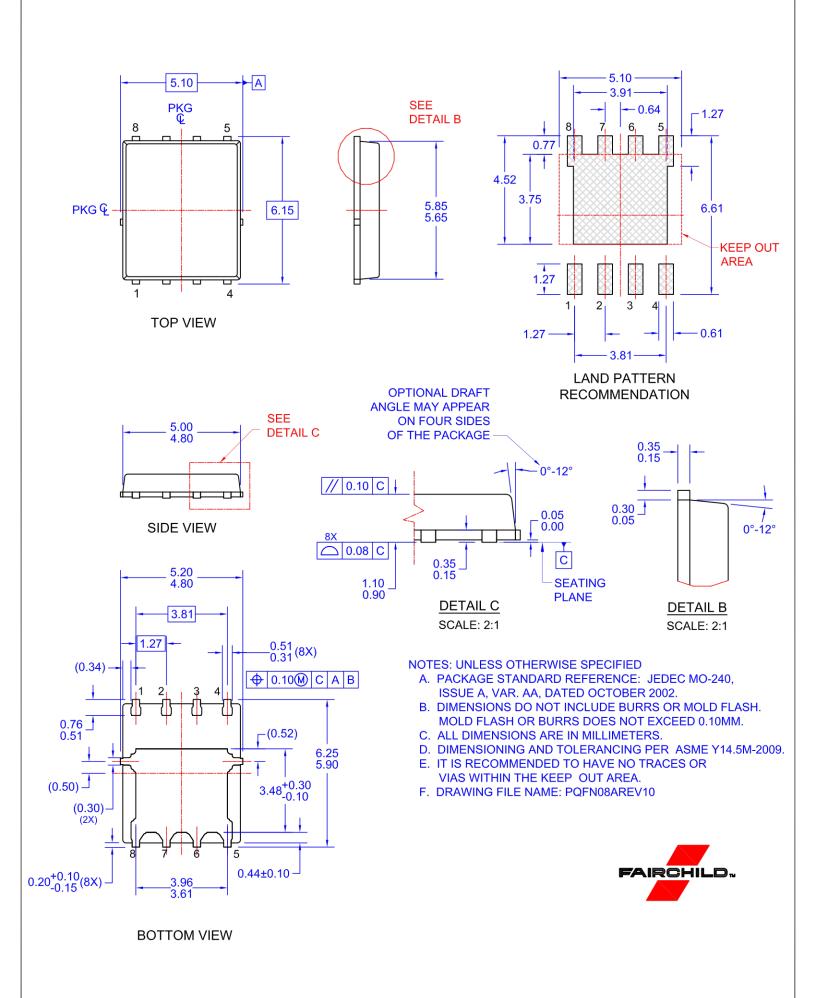


Figure 13. Transient Thermal Response Curve



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